

# **SYSTEM AND METHOD FOR EFFICIENTLY PERFORMING A PATTERN MATCHING PROCEDURE**

## **BACKGROUND SECTION**

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### **1. Field of Invention**

This invention relates generally to techniques for analyzing electronic data, and relates more particularly to a system and method for efficiently  
10 performing a pattern matching procedure.

### **2. Description of the Background Art**

Implementing efficient methods for analyzing electronic data is a  
15 significant consideration for designers and manufacturers of contemporary electronic devices. However, efficiently analyzing data with electronic devices may create substantial challenges for system designers. For example, enhanced demands for increased device functionality and performance may require more system processing power and require additional hardware  
20 resources. An increase in processing or hardware requirements may also result in a corresponding detrimental economic impact due to increased production costs and operational inefficiencies.

Furthermore, enhanced device capability to perform various advanced analysis operations may provide additional benefits to a system user, but  
25 may also place increased demands on the control and management of various device components. For example, an enhanced electronic device that efficiently analyses and manipulates digital image data may benefit from an efficient implementation because of the large amount and complexity of the digital data involved.

30 Due to growing demands on system resources and substantially increasing data magnitudes, it is apparent that developing new techniques for analyzing electronic data is a matter of concern for related electronic

technologies. Therefore, for all the foregoing reasons, developing efficient systems for analyzing electronic data remains a significant consideration for designers, manufacturers, and users of contemporary electronic devices.

## SUMMARY

In accordance with the present invention, a system and method are disclosed for efficiently performing a pattern matching procedure. In one  
5 embodiment, during an enrollment procedure, an enrollment manager obtains an initial reference image from any appropriate source. In certain embodiments, the initial reference image may correspond to a given individual's fingerprint or face.

The enrollment manager may then perform a Fast Fourier Transform  
10 (FFT) procedure to convert the initial reference image (having individual pixels expressed as real numbers in the spatial domain) into an FFT reference image (having individual pixel values expressed as complex numbers in the frequency domain). In certain embodiments, the enrollment manager may perform a binarization procedure to convert the complex pixel values (with  
15 both real and imaginary values) from the FFT reference image into corresponding binarized pixel values of a binarized reference image.

In a first binarization step, in order to conserve system resources such as processing requirements and memory requirements, the enrollment manager may substitute a decimal value of "1" for all complex coefficients  
20 greater than or equal to zero, and may also substitute a decimal value of "-1" for all complex coefficients less than zero. The foregoing initial binarization values may then be utilized for any further calculations during the pixel matching procedure.

In a second binarization step, for purposes of conserving memory  
25 resources, the enrollment manager may create stored binarization values by substituting a binary value of "1" for all complex coefficients of the initial binarization values that are equal to "-1", and also by substituting a binary value of "0" for all complex coefficients of the initial binarization values that are equal to "1". Each of the complex coefficients may thus efficiently and  
30 effectively be expressed with a single binary bit.

Due to properties of data subject to Fast Fourier Transforms, the foregoing binarized reference image exhibits symmetrical characteristics

across the complex pixel values. In certain embodiments, in order to conserve system resources such as processing requirements and memory requirements, the enrollment manager may perform a symmetrical reduction procedure on the binarized reference image to produce a reduced reference  
5 image. For example, in certain embodiments, a large portion of the right-hand pixels from the binarized reference image may be discarded before the binarized reference image is stored as a reference template.

In certain embodiments, during a verification procedure, a verification manager obtains an initial test image from any appropriate source. In certain  
10 embodiments, the initial test image may correspond to a given individual's fingerprint or face that is captured for comparison with the foregoing reference template for purposes of verifying that individual's identity.

The verification manager may perform a Fast Fourier Transform (FFT) procedure to convert the initial test image (having individual pixels expressed  
15 as real numbers in the spatial domain) into an FFT test image (having individual pixel values expressed as complex numbers in the frequency domain). As discussed above, due to properties of data subject to Fast Fourier Transforms, the FFT test image exhibits symmetrical characteristics across the complex pixel values.

20 In certain embodiments, in order to conserve system resources such as processing requirements and memory requirements, the verification manager may perform a symmetrical reduction procedure on the FFT test image to produce a reduced test image. For example, in certain embodiments, a large portion of the right-hand pixels of the FFT test image may be discarded before  
25 the FFT test image is stored.

The verification manager then performs a multiplication procedure by multiplying corresponding complex pixel values from the reference template and the reduced test image to produce a reduced FFT correlation image. In certain embodiments, the verification manager may efficiently utilize a  
30 multiplication lookup table to perform the foregoing multiplication procedure. The verification manager may perform a symmetrical regeneration procedure

to regenerate a full FFT correlation image from the reduced FFT correlation image.

Next, the verification manager may perform an inverse FFT procedure to convert the FFT correlation image (in the frequency domain) into a final correlation image (in the spatial domain). In certain embodiments, the verification manager may then discard all imaginary portions of the pixel values from the final correlation image to produce a real correlation image. The verification manager may also perform an FFT shift procedure upon pixels from the real correlation image to center a pixel magnitude peak of a corresponding correlation graph.

The verification manager may then compute a peak side-lobe ratio (PSR) value that represents a relative amount of correlation between a given initial reference image and a given initial test image. If the foregoing PSR is over a pre-determined verification threshold value, then the verification manager may approve the particular test image as a pattern match for the corresponding initial reference image to complete the pattern matching procedure. The foregoing techniques therefore provide an improved system and method for efficiently performing a pattern matching procedure, in accordance with the present invention.

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## BRIEF DESCRIPTION OF THE DRAWINGS

FIG. 1 is a block diagram for one embodiment of an electronic device, in accordance with the present invention;

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FIG. 2 is a block diagram for one embodiment of the memory of FIG. 1, in accordance with the present invention;

FIG. 3 is a diagram illustrating a pattern matching procedure, in accordance with one embodiment of the present invention;

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FIG. 4 is a diagram illustrating one embodiment of a symmetrical reduction procedure, in accordance with the present invention;

FIG. 5 is a diagram for one embodiment of a multiplication lookup table, in accordance with the present invention;

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FIG. 6 is a diagram for one embodiment of a correlation graph, in accordance with the present invention;

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FIG. 7 is a flowchart of method steps for performing an enrollment procedure, in accordance with one embodiment of the present invention; and

FIGS. 8A and 8B are flowcharts of method steps for performing a verification procedure, in accordance with one embodiment of the present invention.

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## DETAILED DESCRIPTION

The present invention relates to an improvement in data analysis techniques. The following description is presented to enable one of ordinary skill in the art to make and use the invention, and is provided in the context of a patent application and its requirements. Various modifications to the disclosed embodiments will be readily apparent to those skilled in the art, and the generic principles herein may be applied to other embodiments. Thus, the present invention is not intended to be limited to the embodiments shown, but is to be accorded the widest scope consistent with the principles and features described herein.

The present invention comprises a system and method for efficiently performing a pattern matching procedure, and may include an enrollment manager that performs an image conversion procedure for converting an initial reference image into a reference template. The image conversion procedure may include at least one of a binarization procedure and a symmetrical reduction procedure to more efficiently utilize system resources such as processing requirements and memory requirements. A verification manager may then convert an initial test image into a transformed test image for combining with the foregoing reference template to produce a correlation image. The verification manager then analyzes matching characteristics of the correlation image to determine whether the initial test image matches the initial reference image

Referring now to FIG. 1, a block diagram for one embodiment of an electronic device 110 is shown, in accordance with the present invention. In the FIG. 1 embodiment, electronic device 110 may include, but is not limited to, a control module 114, a capture subsystem 118, a system bus 138, and a display 134. In the FIG. 1 embodiment, capture subsystem 118 may be optically coupled to a target object, and may also be electrically coupled via system bus 138 to control module 114.

In alternate embodiments, electronic device 110 may readily include various other components in addition to, or instead of, those components discussed in conjunction with the FIG. 1 embodiment. In addition, the present invention may be embodied in any appropriate type of electronic device. For example, electronic device 110 may readily be implemented as a computer, an image scanner device, a camera device, or an electronic security device.

In the FIG. 1 embodiment, control module 114 may include, but is not limited to, a central processing unit (CPU) 122, a memory 126, and one or more input/output interface(s) (I/O) 130. CPU 122, memory 126, and I/O 130 preferably are each coupled to, and communicate, via common system bus 138 that also communicates with capture subsystem 118. In alternate embodiments, control module 114 may readily include various other components in addition to, or instead of, those components discussed in conjunction with the FIG. 1 embodiment.

In the FIG. 1 embodiment, CPU 122 may be implemented to include any appropriate microprocessor device. Alternately, CPU 122 may be implemented using any other appropriate technology. For example, CPU 122 may be implemented to include certain application-specific integrated circuits (ASICs) or other appropriate electronic devices. Memory 126 may be implemented as one or more appropriate storage devices, including, but not limited to, read-only memory, random-access memory, and various types of non-volatile memory, such as floppy disc devices, hard disc devices, or flash memory. I/O 130 may provide one or more effective interfaces for facilitating communications between electronic device 110 and any external entity, including a system user or another electronic device. I/O 130 may be implemented using any appropriate input and/or output devices.

In the FIG. 1 embodiment, capture subsystem 118 may include, but is not limited to, an image sensor that captures image data corresponding to a target object via reflected light impacting the image sensor along an optical path. The image sensor, which may include a charge-coupled



device (CCD), may responsively generate a set of image data representing the target object. The image data may then be routed over system bus 138 to control module 114 for appropriate processing and storage. The functionality and implementation of electronic device 110 are further  
5 discussed below in conjunction with FIGS. 2-8B.

Referring now to FIG. 2, a block diagram for one embodiment of the FIG. 1 memory 126 is shown, in accordance with the present invention. In the FIG. 2 embodiment, memory 126 may preferably include, but is not  
10 limited to, a device application 210, an enrollment manager 214, a verification manager 218, one or more reference templates 222, and temporary storage 226. In alternate embodiments, memory 126 may readily include various other components in addition to, or instead of, those components discussed in conjunction with the FIG. 2 embodiment.

15 In the FIG. 2 embodiment, device application 210 may include program instructions that are preferably executed by CPU 122 (FIG. 1) to perform various functions and operations for electronic device 110. The particular nature and functionality of device application 210 typically vary depending upon factors such as the type and particular use of the corresponding  
20 electronic device 110.

In the FIG. 2 embodiment, electronic device 110 may utilize enrollment manager 214 for performing an enrollment procedure to create and store one or more reference templates 222 for performing a pattern matching procedure. In the FIG. 2 embodiment, electronic device 110 may utilize  
25 verification manager 214 for performing a verification procedure to compare a test image with one of the reference templates 222 to complete the foregoing pattern matching procedure. Temporary storage 226 may provide storage locations on a temporary basis for any appropriate type of information or data. The utilization of enrollment manager 214 and verification manager  
30 218 are further discussed below in conjunction with FIGS. 7-8B.

Referring now to FIG. 3, a diagram for illustrating a pattern matching procedure is shown, in accordance with one embodiment of the present invention. In alternate embodiments of the present invention, pattern matching procedures may readily utilize various techniques that are different from those discussed in conjunction with the FIG. 3 embodiment.

In the FIG. 3 embodiment, during an enrollment procedure, an enrollment manager 214 obtains an initial reference image 314 from any appropriate source. For example, capture subsystem 118 may capture an initial reference image 314 corresponding to any desired identification pattern. In certain embodiments, the initial reference image 314 may correspond to a given individual's fingerprint or face.

In the FIG. 3 embodiment, enrollment manager 214 may perform a Fast Fourier Transform (FFT) procedure to convert initial reference image 314 (having individual pixels expressed as real numbers in the spatial domain) into an FFT reference image 318 (having individual pixel values expressed as complex numbers in the frequency domain). In certain embodiments, enrollment manager 214 may perform a binarization procedure to convert the complex pixel values (with both real and imaginary values) from FFT reference image 318 into corresponding binarized pixel values of a binarized reference image.

In a first binarization step, in order to conserve system resources such as processing requirements and memory, enrollment manager 214 may substitute a decimal value of "1" for all complex coefficients greater than or equal to zero, and may also substitute a decimal value of "-1" for all complex coefficients less than zero. For example, a complex pixel value of  $3 + 4j$  would therefore be converted to a initial binarization value of  $1 + j$  during the foregoing initial binarization step. The foregoing initial binarization values may then be utilized for any further calculations during the pixel matching procedure.

In a second binarization step, for purposes of conserving storage in memory 126, enrollment manager 214 may create stored binarization values by substituting a binary value of "1" for all complex coefficients of the initial

binarization values that are equal to “-1”, and also by substituting a binary value of “0” for all complex coefficients of the initial binarization values that are equal to “1”. Each of the complex coefficients may thus efficiently and effectively be expressed with a single binary bit. Enrollment manager 214 or  
5 verification manager 218 may preferably convert the stored binarization values into initial binarization values for purposes of performing any required mathematical calculations using FFT reference image 318.

In the FIG. 3 embodiment, due to properties of data subject to Fast Fourier Transforms, FFT reference image 318 (or the foregoing binarized  
10 reference image) exhibits symmetrical characteristics across the complex pixel values. In certain embodiments, in order to conserve system resources such as processing requirements and memory requirements, enrollment manager 214 may perform a symmetrical reduction procedure on FFT  
15 reference image 318 (or on the binarized reference image) to produce a reduced reference image. For example, in certain embodiments, a large portion of the right-hand pixels of FFT reference image 318 (or the binarized reference image) may be discarded before FFT reference image 318 or the binarized reference image is stored as reference template (FIG. 2). The foregoing symmetrical reduction procedure is further discussed below in  
20 conjunction with FIG. 4.

In the FIG. 3 embodiment, during a verification procedure, a verification manager 218 obtains an initial test image 322 from any appropriate source. For example, capture subsystem 118 may capture an initial test image 322 corresponding to any desired identification pattern. In  
25 certain embodiments, the initial test image 322 may correspond to a given individual’s fingerprint or face that is captured to compare with a reference template 222 (FIG. 2) for purposes of verifying that individual’s identity.

In the FIG. 3 embodiment, verification manager 218 may perform a Fast Fourier Transform (FFT) procedure to convert initial test image 322  
30 (having individual pixels expressed as real numbers in the spatial domain) into an FFT test image 326 (having individual pixel values expressed as complex numbers in the frequency domain). In certain embodiments,

verification manager 218 may perform a binarization procedure to convert the complex pixel values (with both real and imaginary values) from FFT test image 326 into corresponding binarized pixel values from a binarized reference image, as discussed above with reference to FFT reference image 318.

In the FIG. 3 embodiment, due to properties of data subject to Fast Fourier Transforms, FFT test image 326 (or the foregoing binarized test image) exhibits symmetrical characteristics across the complex pixel values. In certain embodiments, in order to conserve system resources such as processing requirements and memory requirements, verification manager 218 may perform a symmetrical reduction procedure on FFT test image 326 (or on the binarized test image) to produce a reduced test image. For example, in certain embodiments, a large portion of the right-hand pixels of FFT test image 326 (or the binarized test image) may be discarded before FFT test image 326 or the binarized test image is stored. The foregoing symmetrical reduction procedure is further discussed below in conjunction with FIG. 4.

In the FIG. 3 embodiment, verification manager 218 may then perform a multiplication procedure by multiplying corresponding complex pixel values from FFT reference 318 (or the reduced reference image) and FFT test image 326 (or the reduced test image) to produce an FFT correlation image 334. In certain embodiments, verification manager 218 may efficiently utilize a multiplication lookup table to perform the multiplication procedure, as discussed below in conjunction with FIG. 5. In appropriate instances, verification manager 218 may perform a symmetrical regeneration procedure to regenerate a full FFT correlation image from a reduced FFT correlation image.

In the FIG. 3 embodiment, verification manager 218 may perform an inverse FFT (IFFT) procedure to convert FFT correlation image 334 (in the frequency domain) into a final correlation image 338 (in the spatial domain). In certain embodiments, verification manager 218 may then discard all imaginary portions of the pixel values from final correlation image 338 to produce a real correlation image. Verification manager 218 may perform a

known FFT shift procedure upon pixels from the real correlation image to center a pixel magnitude peak of a corresponding correlation graph that is further discussed below in conjunction with FIG. 6.

Verification manager 218 may then compute a peak side-lobe ratio (PSR) value that represents a relative amount of correlation between a given initial reference image 314 and a given initial test image 322. If the foregoing PSR is over a pre-determined verification threshold value, then verification manager 218 may approve the particular test image 322 as a pattern match for the corresponding initial reference image 314 to complete the pattern matching procedure. The foregoing techniques therefore provide an improved system and method for efficiently performing a pattern matching procedure, in accordance with the present invention.

Referring now to FIG. 4, a diagram 410 illustrating one embodiment of a symmetrical reduction procedure is shown, in accordance with the present invention. In alternate embodiments, symmetrical reduction procedures may utilize various techniques that are different from those discussed in conjunction with the FIG. 4 embodiment.

In the FIG. 4 embodiment, due to properties of frequency domain data that has been processed with Fast Fourier Transforms, an FFT image (such as that shown in diagram 410) preferably exhibits symmetrical characteristics across the individual complex pixel values. In certain embodiments, in order to conserve system resources such as processing requirements and memory use, an electronic device 110 or other appropriate entity may perform a symmetrical reduction procedure on the FFT image to produce a reduced FFT image.

In the FIG. 4 embodiment, for purposes of illustration, the FFT image of diagram 410 is shown to be 96 pixels wide and 96 pixels high. During a symmetrical reduction procedure, because of the symmetrical characteristics of the FFT image from left to right, the FFT image may be divided into a reduced portion A 414 on the left of the FFT image, and a discarded portion B 418 on the right of the FFT image. In the FIG. 4 embodiment, reduced

portion A 414 may be 49 pixels wide, and discarded portion B may be 47 pixels wide. In certain embodiments, the discarded pixels corresponding to discarded portion B 418 may advantageously be regenerated by verification manager 218 in a symmetrical regeneration procedure that is performed by  
5 utilizing the same symmetrical characteristics and properties of frequency domain data processed with Fast Fourier Transforms.

Referring now to FIG. 5, a diagram for one embodiment of a multiplication lookup table 510 is shown, in accordance with the present  
10 invention. The multiplication look-up table (multiplication LUT) 510 of FIG. 5 is presented for purposes of illustration, and in alternate embodiments of the present invention, multiplication lookup table 510 may readily include other elements and components in various configurations that are different from that discussed in conjunction with the FIG. 5 embodiment.

15 In the FIG. 5 example, as also discussed above in conjunction with FIG. 3, verification manager 218 may perform a multiplication procedure by multiplying pixel values from a reference template 222 (FIG. 2) with corresponding pixel values from an FFT test image 326 to produce an FFT correlation image 334. In the FIG. 5 embodiment, to conserve system  
20 resources such as processing and memory utilization, verification manager 218 may efficiently utilize multiplication LUT 510 to perform the foregoing multiplication procedure.

In the FIG. 5 embodiment, due to the binarization procedure discussed above in conjunction with FIG. 3, all complex values from either reference  
25 template 222 or FFT test image 326 may be expressed with one of only four complex numbers (either  $1 + j$ ,  $1 - j$ ,  $-1 + j$ , or  $-1 - j$ ). In the FIG. 5 embodiment, multiplication LUT 510 may thus be efficiently implemented with only sixteen table values. In the FIG. 5 embodiment, a vertical reference-pixel index column includes a reference pixel value ( $1 + j$ ) (514(a)), a  
30 reference pixel value ( $1 - j$ ) (514(b)), a reference pixel value ( $-1 + j$ ) (514(c)), and a reference pixel value ( $-1 - j$ ) (514(d)).

Similarly, a horizontal test-pixel index row includes a test pixel value  $(1 + j)$  (518(a)), a test pixel value  $(1 - j)$  (518(b)), a test pixel value  $(-1 + j)$  (518(c)), and a test pixel value  $(-1 - j)$  (518(d)). Verification manager 218 or other appropriate entity may perform the foregoing multiplication procedure by indexing an appropriate table value in multiplication LUT 510. For example, verification manager 218 may locate table value 522(a) with reference pixel value  $(1 + j)$  (514(a)) and test pixel value  $(-1 - j)$  (518(d)).

Referring now to FIG. 6, a diagram for one embodiment of a correlation graph 610 is shown, in accordance with the present invention. The correlation graph 610 of FIG. 6 is presented for purposes of illustration, and in alternate embodiments of the present invention, correlation graph 610 may readily include other elements and components in various configurations that are different from those discussed in conjunction with the FIG. 6 embodiment.

In the FIG. 6 embodiment, correlation graph 610 is shown as a three-dimensional graph that includes a vertical Z axis 614 corresponding to pixel magnitudes. Correlation graph 610 also includes a horizontal X axis 622 and a horizontal Y axis 618 that correspond to respective vertical X and horizontal Y pixel coordinates from a given correlation image. In the FIG. 6 example, correlation graph 610 includes a correlation curve 626 that represents pixel values from a final correlation image 338 (FIG. 3) or other correlation image created from an initial reference image 314 and an initial test image 322. In the FIG. 6 embodiment, correlation curve 626 includes a peak value 630 that represents a maximum correlation pixel that has the greatest magnitude.

Verification manager 218 may utilize pixel values from correlation graph 610 to calculate a peak side-lobe ration (PSR) for verifying or rejecting a given initial test image 322 as a pattern match for a corresponding reference template 222, as discussed above in conjunction with FIG. 3.

In certain embodiments, the foregoing PSR may be calculated according to the following formula:

$$\text{PSR} = (\text{Peak Value} - \text{Mean Value}) / \text{STD}$$

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where PSR is the peak side-lobe ratio, Peak Value is a correlation image pixel with the greatest magnitude, Mean Value is an arithmetical mean value of correlation image pixels in a pre-defined side-lobe area surrounding the foregoing peak value 630, and STD is the standard deviation of correlation  
10 image pixels in the pre-defined side-lobe area. The creation and utilization of correlation graph 610 is further discussed below in conjunction with FIG. 8B.

Referring now to FIG. 7, a flowchart of method steps for performing an enrollment procedure is shown, in accordance with one embodiment of the  
15 present invention. The FIG. 7 embodiment is presented for purposes of illustration, and in alternate embodiments, the present invention may readily utilize various other steps and sequences than those discussed in conjunction with the FIG. 7 embodiment.

In the FIG. 7 embodiment, in step 710, an initial reference image 314  
20 (FIG. 3) may be obtained from any appropriate image source. Then, in step 714, an enrollment manager 214 may perform a Fast Fourier Transform (FFT) procedure upon initial reference image 314 to produce an FFT reference image 318. In accordance with certain embodiments of the present invention, in step 718, enrollment manager 214 may next perform a  
25 binarization procedure upon FFT reference image 318 to produce a binarized reference image, as discussed above in conjunction with FIG. 3.

In step 722, enrollment manager 214 may perform a symmetrical reduction procedure upon the binarized reference image to produce a reduced reference image, as discussed above in conjunction with FIGS. 3-4. Finally,  
30 in step 726, enrollment manager 214 may store the reduced reference image into memory 126 as a reference template 222. The FIG. 7 process may then terminate.



Referring now to FIGS 8A and 8B, a flowchart of method steps for performing a verification procedure is shown, in accordance with one embodiment of the present invention. The FIG. 8A and 8B embodiment is presented for purposes of illustration, and in alternate embodiments, the present invention may readily utilize various other steps and sequences than those discussed in conjunction with FIGS. 8A and 8B.

In FIG. 8A, in step 810, an initial test image 322 (FIG. 3) may be obtained from any appropriate image source. Then, in step 814, a verification manager 218 performs a Fast Fourier Transform (FFT) procedure upon initial test image 322 to produce an FFT test image 326. In accordance with certain embodiments of the present invention, in step 814, verification manager 218 may also perform a binarization procedure upon FFT test image 326 to produce a binarized reference image, as discussed above in conjunction with FIG. 3.

In step 818, verification manager 218 performs a symmetrical reduction procedure upon FFT test image 326 (or the foregoing binarized test image) to produce a reduced test image, as discussed above in conjunction with FIGS. 3-4. Then, in step 822, verification manager 218 or other appropriate entity may perform a complex conjugation procedure upon the reference template 222 generated by the process discussed above in conjunction with FIG. 7 to thereby produce a conjugated reference image.

In the FIG. 8A embodiment, the foregoing complex conjugation procedure simply converts each pixel value from a reference template 222 into a corresponding complex conjugate value by changing the arithmetic operation that connects real and imaginary portions of the complex values for each pixel in reference template 222. For example, a "plus" sign is changed to a "minus" sign, and similarly, a "minus" sign is changed to a "plus" sign.

In step 826, verification manager 218 performs a multiplication procedure with the foregoing conjugated reference image and the foregoing reduced test image to produce a reduced FFT correlation image, as discussed above in conjunction with FIGS. 3 and 5. Then, in step 830, verification

manager 218 performs a symmetrical regeneration procedure to produce a full FFT correlation image, as discussed above in conjunction with FIGS. 3 and 4.

The FIG. 8A process then proceeds to step 834 of FIG. 8B in which verification manager 218 performs an inverse FFT procedure upon the foregoing full FFT correlation image to generate a complex correlation image. In step 838, verification manager 218 discards imaginary values from each pixel value of the complex correlation image to produce a real correlation image. In step 842, verification manager 218 performs an FFT shift procedure to generate a correlation graph 610 that represents pixels from the real correlation image, as discussed above in conjunction with FIGS. 3 and 6.

In step 846, verification manager 218 then computes a peak side-lobe ratio (PSR) from correlation graph 610, as discussed above in conjunction with FIG. 6. In step 850, verification manager 218 determines whether the calculated PSR is over a pre-determined verification threshold. If the PSR is not over the pre-determined verification threshold, then in step 854, verification manager 218 rejects initial test image 322 as a pattern match for the corresponding initial reference image 314.

However, in step 858, if the PSR of step 846 is over the pre-determined verification threshold, then verification manager 218 approves initial test image 322 as a pattern match for the corresponding initial reference image 314, and the FIG. 8B process may terminate. The present invention therefore provides an improved system and method for efficiently performing a pattern matching procedure.

The invention has been explained above with reference to certain embodiments. Other embodiments will be apparent to those skilled in the art in light of this disclosure. For example, the present invention may readily be implemented using configurations and techniques other than those described in the embodiments above. Additionally, the present invention may effectively be used in conjunction with systems other than those described above. Therefore, these and other variations upon the discussed

embodiments are intended to be covered by the present invention, which is limited only by the appended claims.